Application/Control No. 10/046,379 Examiner Thach H Bui Applicant(s)/Patent Under Reexamination EAVENSON ET AL. Art Unit Page 1 of 1

Notice of References Cited

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,253,416	07-2001	Lauer et al.	15/361
	В	US-			
	С	US-	•		
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Ø			-		
	R					
	S					
	Т			-		

NON-PATENT DOCUMENTS

	NON-I ATENT DOCUMENTO							
*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)							
	U							
	v							
	w							
	×							

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

MIT